# N-Channel 800V (D-S) Super Junction Power MOSFET

| PRODUCT SUMMARY | | |
|---|---|---|
| $V_{DS}$ (V) | 800 | |
| $R_{DS(on)}$ (Ω) | $V_{GS}$ = 10 V | 1.3 |
| $Q_g$ (Max.) (nC) | 200 | |
| $Q_{gs}$ (nC) | 24 | |
| $Q_{gd}$ (nC) | 110 | |
| Configuration | Single | |

## FEATURES

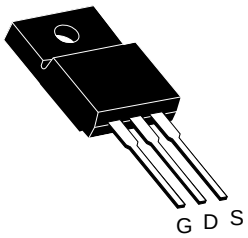
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

Available

RoHS* COMPLIANT

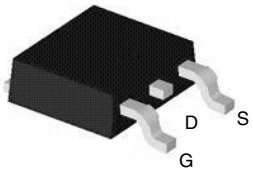
TO-220 Pin Configuration **TO-220 FULLPAK**


Top View



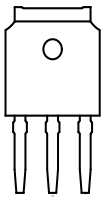

Top View

TO-252 Pin Configuration

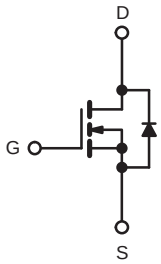



Top View

**TO-251**




Top View




N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS ($T_C$ = 25 °C, unless otherwise noted) | | | | | |
|---|---|---|---|---|---|
| **PARAMETER** | | | **SYMBOL** | **LIMIT** | **UNIT** |
| Drain-Source Voltage | | | $V_{DS}$ | 800 | V |
| Gate-Source Voltage | | | $V_{GS}$ | ± 20 | |
| Continuous Drain Current | $V_{GS}$ at 10 V | $T_C$ = 25 °C | $I_D$ | 5 | A |
| | | $T_C$ = 100 °C | | 3.9 | |
| Pulsed Drain Current[a] | | | $I_{DM}$ | 21 | |
| Linear Derating Factor | | | | 1.5 | W/°C |
| Single Pulse Avalanche Energy[b] | | | $E_{AS}$ | 770 | mJ |
| Repetitive Avalanche Current[a] | | | $I_{AR}$ | 7.8 | A |
| Repetitive Avalanche Energy[a] | | | $E_{AR}$ | 19 | mJ |
| Maximum Power Dissipation | $T_C$ = 25 °C | | $P_D$ | 190 | W |
| Peak Diode Recovery dV/dt[c] | | | dV/dt | 2.0 | V/ns |
| Operating Junction and Storage Temperature Range | | | $T_J$, $T_{stg}$ | - 55 to + 150 | °C |
| Soldering Recommendations (Peak Temperature) | for 10 s | | | 300[d] | |
| Mounting Torque | 6-32 or M3 screw | | | 10 | lbf · in |
| | | | | 1.1 | N · m |

**Notes**

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. $V_{DD}$ = 50 V, starting $T_J$ = 25 °C, L = 23 mH, $R_g$ = 25 Ω, $I_{AS}$ = 7.8 A (see fig. 12).
c. $I_{SD}$ ≤ 7.8 A, dI/dt ≤ 140 A/µs, $V_{DD}$ ≤ 600 V, $T_J$ ≤ 150 °C.
d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

## THERMAL RESISTANCE RATINGS

| PARAMETER | SYMBOL | TYP. | MAX. | UNIT |
|---|---|---|---|---|
| Maximum Junction-to-Ambient | $R_{thJA}$ | - | 40 | °C/W |
| Case-to-Sink, Flat, Greased Surface | $R_{thCS}$ | 0.24 | - | |
| Maximum Junction-to-Case (Drain) | $R_{thJC}$ | - | 0.65 | |

## SPECIFICATIONS ($T_J$ = 25 °C, unless otherwise noted)

| PARAMETER | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---|---|---|---|---|---|---|
| **Static** | | | | | | |
| Drain-Source Breakdown Voltage | $V_{DS}$ | $V_{GS}$ = 0 V, $I_D$ = 250 µA | 800 | - | - | V |
| $V_{DS}$ Temperature Coefficient | $\Delta V_{DS}/T_J$ | Reference to 25 °C, $I_D$ = 1 mA | - | 0.98 | - | V/°C |
| Gate-Source Threshold Voltage | $V_{GS(th)}$ | $V_{DS}$ = $V_{GS}$, $I_D$ = 250 µA | 2.0 | - | 4.0 | V |
| Gate-Source Leakage | $I_{GSS}$ | $V_{GS}$ = ± 20 V | - | - | ± 100 | nA |
| Zero Gate Voltage Drain Current | $I_{DSS}$ | $V_{DS}$ = 800 V, $V_{GS}$ = 0 V | - | - | 100 | µA |
| | | $V_{DS}$ = 640 V, $V_{GS}$ = 0 V, $T_J$ = 125 °C | - | - | 500 | |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $V_{GS}$ = 10 V, $I_D$ = 3.7 A[b] | - | - | 1.2 | Ω |
| Forward Transconductance | $g_{fs}$ | $V_{DS}$ = 100 V, $I_D$ = 3.7 A[b] | 5.6 | - | - | S |
| **Dynamic** | | | | | | |
| Input Capacitance | $C_{iss}$ | $V_{GS}$ = 0 V, $V_{DS}$ = 25 V, f = 1.0 MHz, see fig. 5 | - | 3100 | - | pF |
| Output Capacitance | $C_{oss}$ | | - | 800 | - | |
| Reverse Transfer Capacitance | $C_{rss}$ | | - | 490 | - | |
| Total Gate Charge | $Q_g$ | $V_{GS}$ = 10 V, $I_D$ = 3.8 A, $V_{DS}$ = 400 V, see fig. 6 and 13[b] | - | - | 200 | nC |
| Gate-Source Charge | $Q_{gs}$ | | - | - | 24 | |
| Gate-Drain Charge | $Q_{gd}$ | | - | - | 110 | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD}$ = 400 V, $I_D$ = 3.8 A, $R_g$ = 6.2 Ω, $R_D$= 52 Ω see fig. 10[b] | - | 19 | - | ns |
| Rise Time | $t_r$ | | - | 38 | - | |
| Turn-Off Delay Time | $t_{d(off)}$ | | - | 120 | - | |
| Fall Time | $t_f$ | | - | 39 | - | |
| Internal Drain Inductance | $L_D$ | Between lead, 6 mm (0.25") from package and center of die contact  | - | 5.0 | - | nH |
| Internal Source Inductance | $L_S$ | | - | 13 | - | |
| **Drain-Source Body Diode Characteristics** | | | | | | |
| Continuous Source-Drain Diode Current | $I_S$ | MOSFET symbol showing the integral reverse p - n junction diode  | - | - | 5.0 | A |
| Pulsed Diode Forward Current[a] | $I_{SM}$ | | - | - | 21 | |
| Body Diode Voltage | $V_{SD}$ | $T_J$ = 25 °C, $I_S$ = 3.8 A, $V_{GS}$ = 0 V[b] | - | - | 1.8 | V |
| Body Diode Reverse Recovery Time | $t_{rr}$ | $T_J$ = 25 °C, $I_F$ = 3.8 A, dI/dt = 100 A/µs[b] | - | 650 | 980 | ns |
| Body Diode Reverse Recovery Charge | $Q_{rr}$ | | - | 3.8 | 5.7 | µC |
| Forward Turn-On Time | $t_{on}$ | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$) | | | | |

**Notes**

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

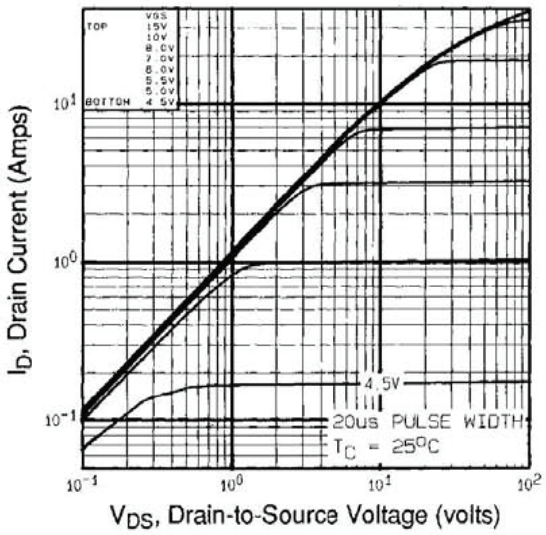



**Fig. 1 - Typical Output Characteristics, $T_C$ = 25 °C**

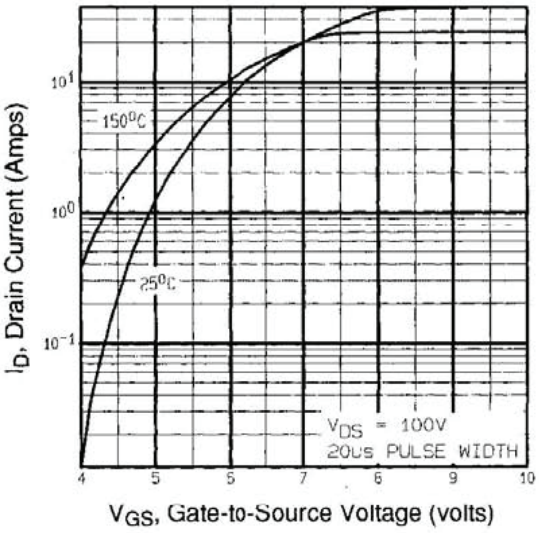



**Fig. 3 - Typical Transfer Characteristics**

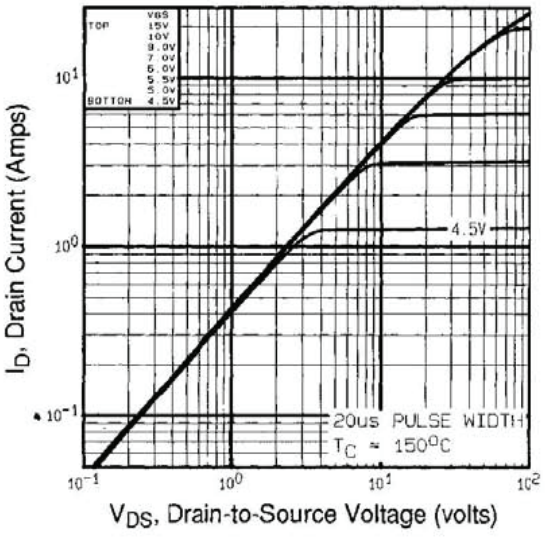



**Fig. 2 - Typical Output Characteristics, $T_C$ = 150 °C**

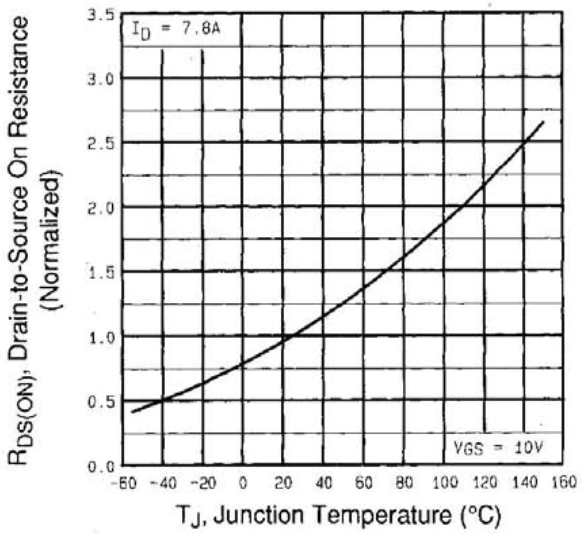



**Fig. 4 - Normalized On-Resistance vs. Temperature**

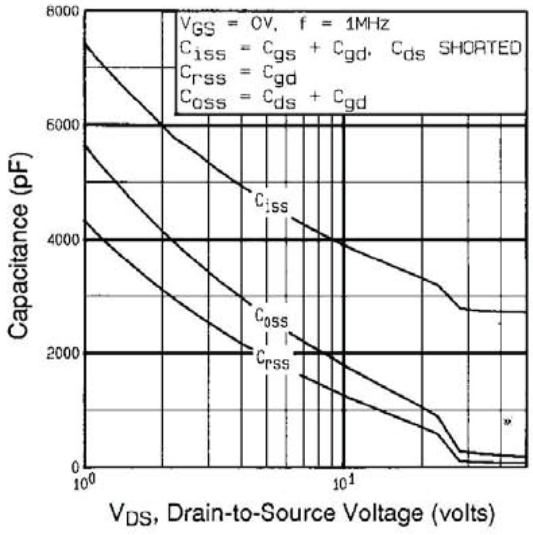



Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

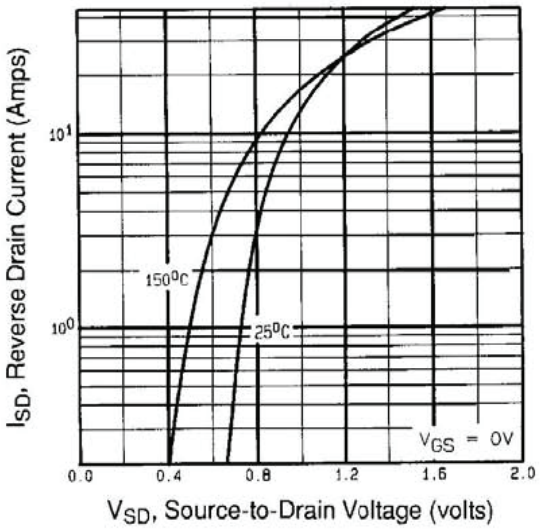



Fig. 7 - Typical Source-Drain Diode Forward Voltage

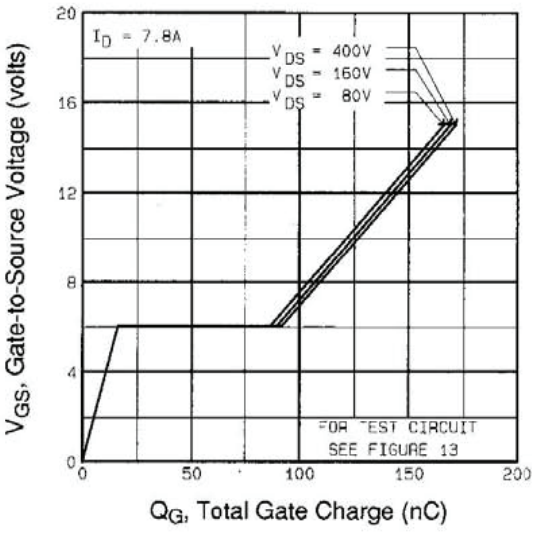



Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

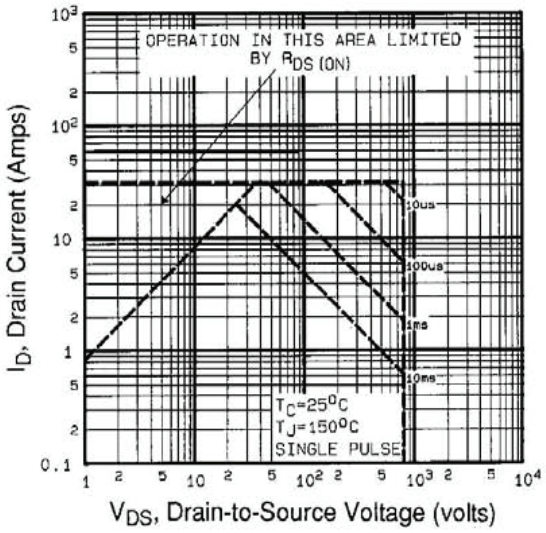



Fig. 8 - Maximum Safe Operating Area

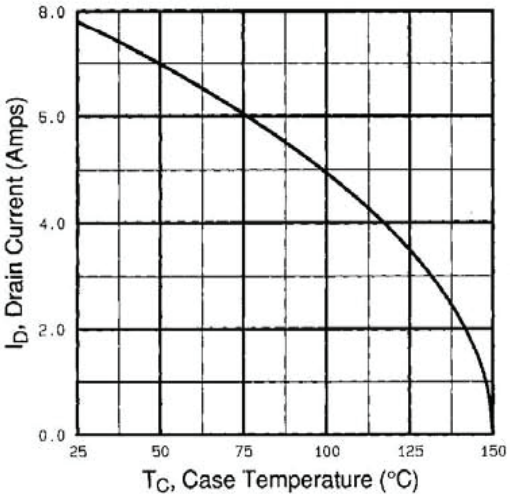



**Fig. 9 - Maximum Drain Current vs. Case Temperature**

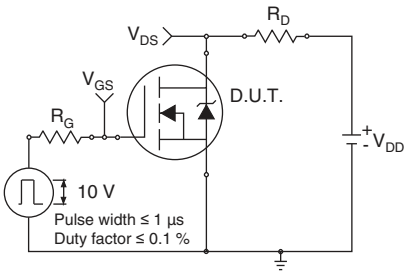



**Fig. 10a - Switching Time Test Circuit**

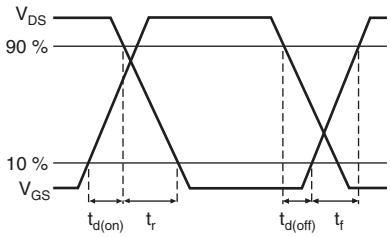



**Fig. 10b - Switching Time Waveforms**

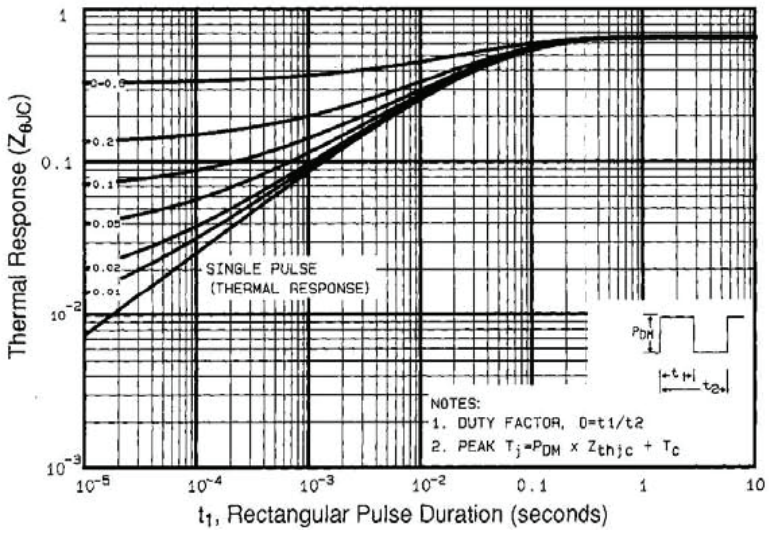



**Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case**

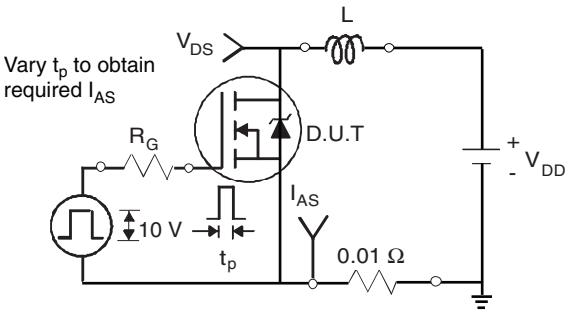



Fig. 12a - Unclamped Inductive Test Circuit

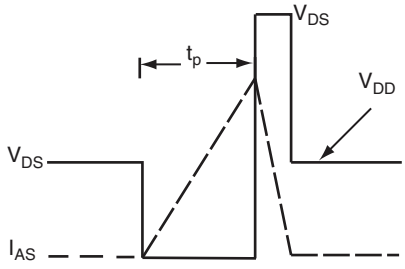



Fig. 12b - Unclamped Inductive Waveforms

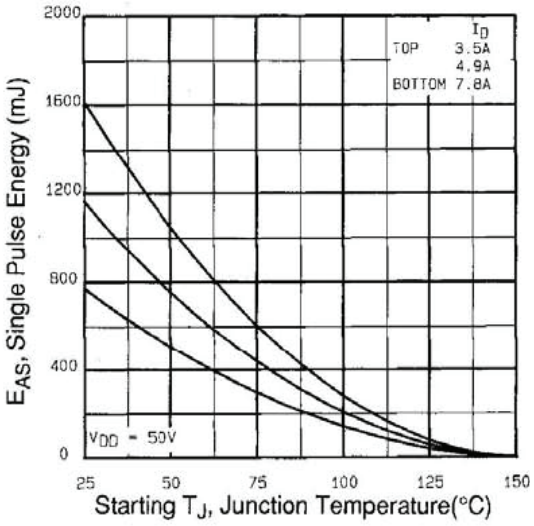



Fig. 12c - Maximum Avalanche Energy vs. Drain Current

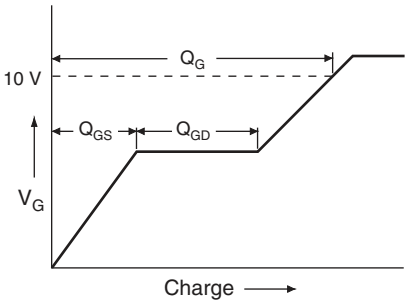



Fig. 13a - Basic Gate Charge Waveform

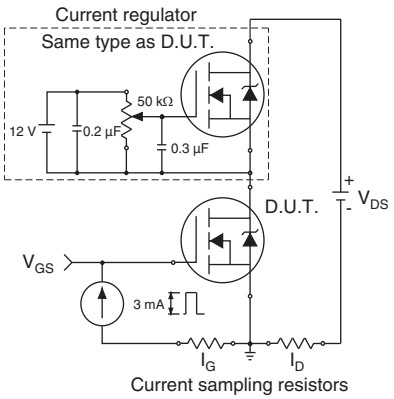
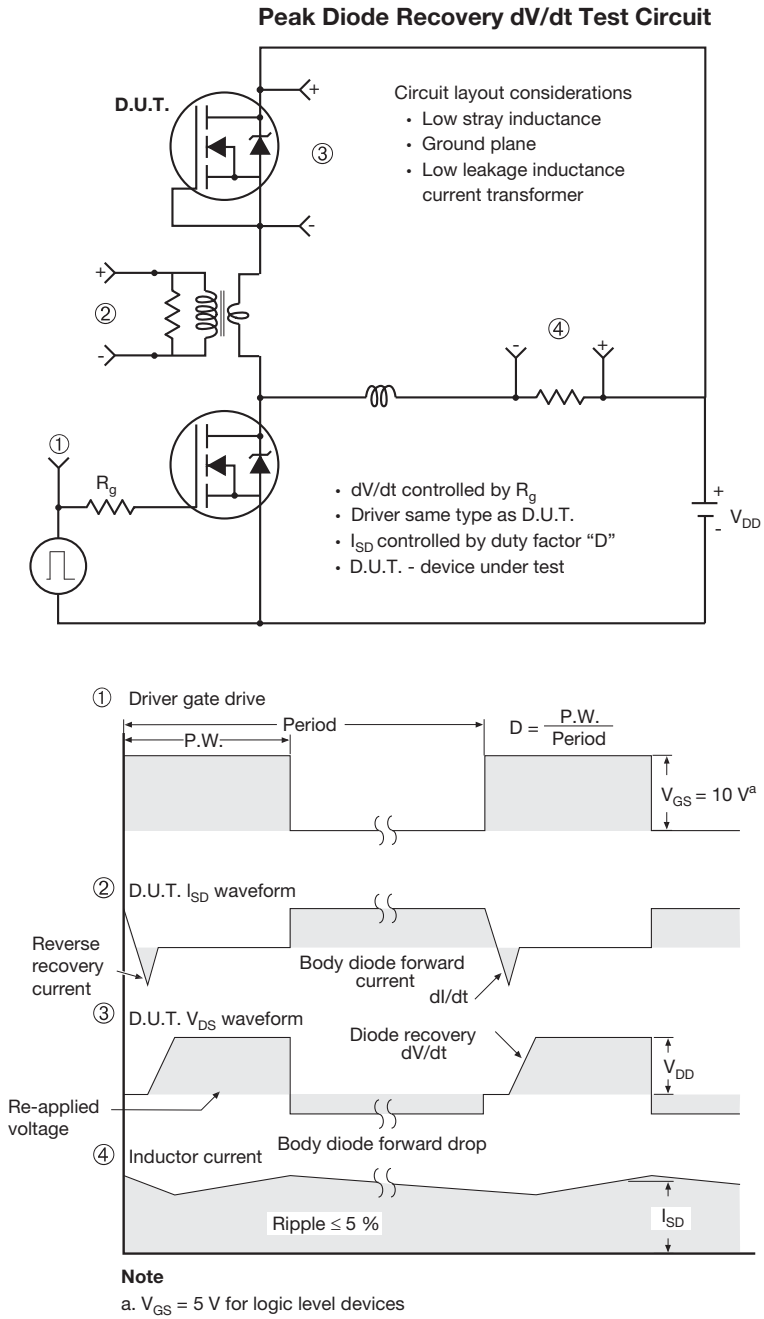



Fig. 13b - Gate Charge Test Circuit




**Note**

a. $V_{GS}$ = 5 V for logic level devices

**Fig. 14 - For N-Channel**

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